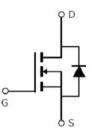


Main Product Characteristics:

V _{DSS}	100V
R _{DS} (on)	4.2mΩ (typ.)
Ι _D	140A





TO-263 (D2PAK)

Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature

Absolute Max Rating:



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Parameter Symbol

Symbol	Parameter	Max.	Units
ID @ Tc = 25°C	Continuous Drain Current, Vos @ 10V ①	140	
ID @ Tc = 100°C	Continuous Drain Current, VGs @ 10V ①	85	А
Ідм	Pulsed Drain Current ②	417	
Pp @Tc = 25°C	Power Dissipation ③	266	W
Vds	Drain-Source Voltage	100	V
Vgs	Gate-to-Source Voltage	± 20	V
Eas	Single Pulse Avalanche Energy @ L=0.5mH	473	mJ
las	Avalanche Current	52	А
Tj Tstg	Operating Junction and Storage Temperature Range	-55 to +150	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
Rejc	Junction-to-case ③		0.47	°C/W
Reja	Thermal Resistance, Junction-to-Ambient ④		62	°C/W

Electrical Characteristics @T_A=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V(BR)DSS	Drain-to-Source breakdown voltage	100	_	_	V	Vgs = 0V, Id = 250µA
RDS(on)	Static Drain-to-Source on-resistance	_	4.2	6	mΩ	Vgs=10V,Id =20A
VGS(th)	Gate threshold voltage	2	_	4	V	Vos = Vgs, Id =250µA
IDSS	Drain-to-Source leakage current	_	_	1	μA	VDS =100V,VGS = 0V
1	Cata ta Cauraa famuard laakara	_	_	100	- 1	Vgs =20V
lgss	Gate-to-Source forward leakage			-100	nA	Vgs = -20V
Qg	Total gate charge	_	43	_		ID = 20A,
Qgs	Gate-to-Source charge		9.5	_	nC	Vds=50V,
Q_{gd}	Gate-to-Drain("Miller") charge		11	_		Vgs = 10V
t d(on)	Turn-on delay time		18	_		Vgs=10V,
tr	Rise time		26	_	Rgen=3Ω	Rgen=3Ω
td(off)	Turn-Off delay time		39	_	ns	VDS=50V
tr	Fall time		12	_		ID = 20A
Ciss	Input capacitance		3858	_		Vgs = 0V
Coss	Output capacitance		407	_	pF	VDS = 100V
Crss	Reverse transfer capacitance	_	17	_		<i>f</i> = 100KHz

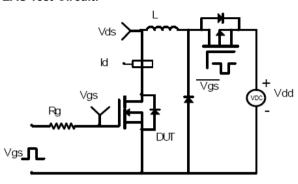
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
ls	Continuous Source Current	_		167	A	MOSFET symbol	
	(Body Diode)					showing the integral reverse	
lsм	Pulsed Source Current	_	_	417	A		
	(Body Diode)					p-n junction diode.	
Vsd	Diode Forward Voltage	_		1.2	V	Is=20A, Vgs=0V	
trr	Reverse Recovery Time		60	_	ns		
Qrr	Reverse Recovery Charge	_	61	_	nC	Is=20A, di/dt=100A/us	

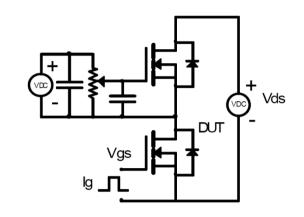


Test Circuits and Waveforms

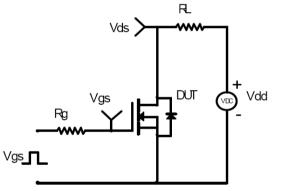




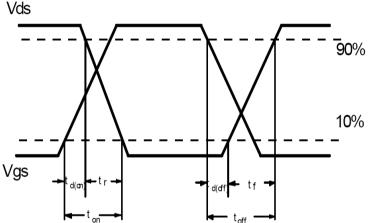
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- 2 Repetitive rating; pulse width limited by max. junction temperature.
- 3 The power dissipation P_D is based on max. junction temperature, using junction-to-case thermal resistance.

(4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}C$.





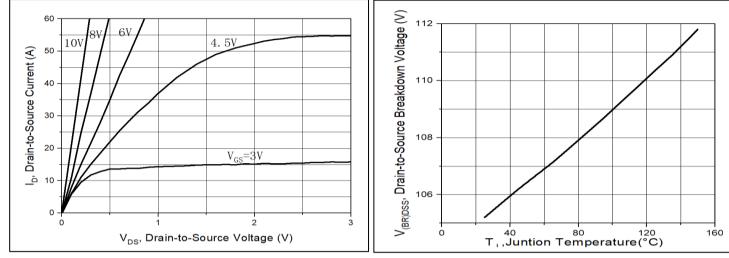


Figure1.Typical Output Characteristics

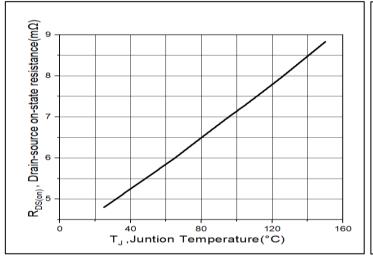


Figure3. RDS(on) vs. Junction Temperature



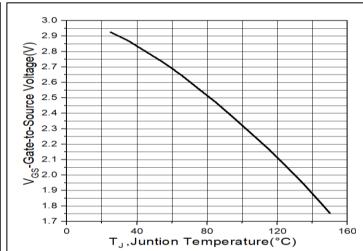


Figure4. Vth vs. Junction Temperature

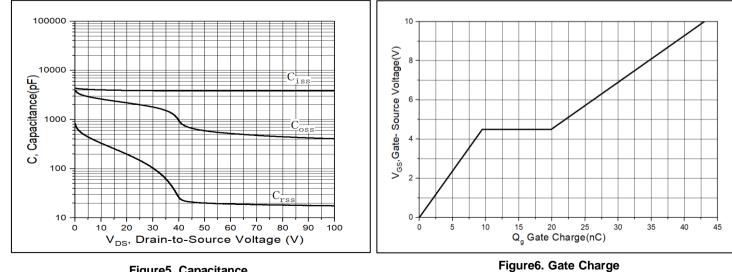


Figure5. Capacitance





Typical Electrical and Thermal Characteristics

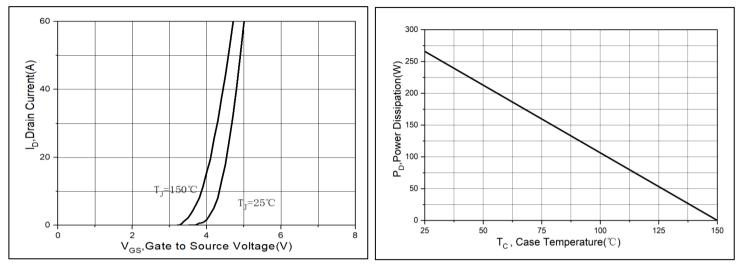


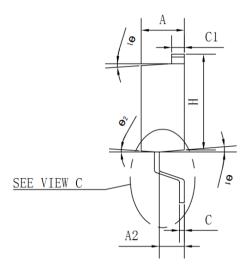
Figure7. Transfer Characteristics

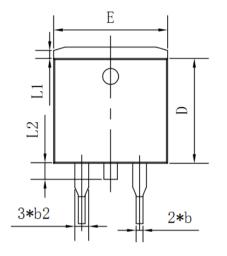
Figure8. Power Dissipation

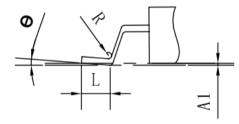


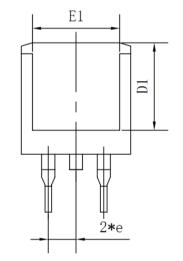
Mechanical Data:

TO-263 Package Outline (Unit:mm) Option 1





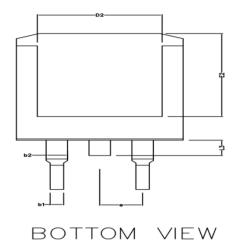


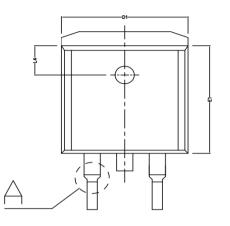


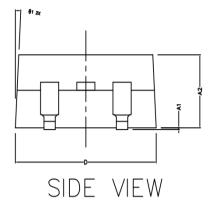
SYMBOL	MIN	NOM	MAX
A	4.35	4.47	4.60
A1	0.09	0.10	0.11
A2	2.30	2.40	2. 50
Ь	0.70	0.80	1.00
b2	1. 25	1.36	1.38
С	0.45	0.50	0. 55
C 1	1.29	1.30	1.31
D	9.10	9.20	9.30
D1	7.90	8.00	8.10
Е	9.85	10.00	10.20
E1	7.90	8.00	8.10
Н	15.30	15.50	15. 70
е	-	2.54	-
L	2.34	2.54	2.74
L1	1.00	1.10	1.20
L2	1.30	1.40	1.50
R	0.24	0.25	0.26
θ	0°	4°	8°
0 1	4°	7°	10°
0 2	0°	3°	6°



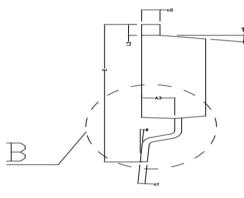
Option 2



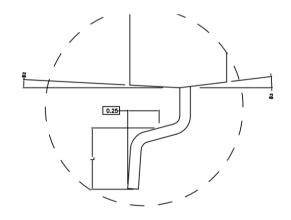


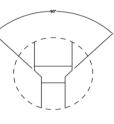


TOP VIEW



SIDE VIEW





DETAIL A

	MIN	NORMAL	MAX				
A1	0.020	-	0.200				
A2	4.470	4.570	4.670				
A3	2.300	2.350	2.400				
b1	0.750	-	0.850				
b2	1.220	-	1.320				
c1	0.500	-	0.550				
c2	1.300	-	1.350				
D	9.780	9.880	9.980				
D1		9.880REF					
D2		7.400REF					
Ε	14.900	15.100	15.300				
E1	9.100	9.200	9.300				
E2		8.100REF					
е		2.540REF					
L	2.100	2.300	2.500				
L2	1.025		1.375				
L3	1.300	1.500	1.700				
L4	2.400	2.500	2.600				
θ1	3° TYPE						
θ2	3* TYPE						
θζ	7° TYPE						
θ4	7° TYPE						
θ	0~8						



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